

# **Enhancement Mode N-Channel Power MOSFET**

 $TO-220/NMOS/68V/\pm20V/2.9V/80A/6.3m\Omega$ 

Rev<sub>0.5</sub>





# 68V, 6.3mΩ, 80A, N-Channel MOSFET

#### 1.Features

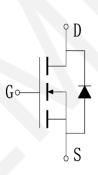
- Advanced Trench Technology
- ◆ Excellent R<sub>DS(ON)</sub> and Low Gate Charge
- ◆ Lead Free
- 100% RG Tested
- ♦ 100% UIS Tested

### 2.Applications

- Load Switch
- PWM Application
- Power Management







Schematic Diagram

#### 3. Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Reel	PCS/CTN.
WX080N07KA	080N07	TO-220	800	4,000

#### 4.Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	Maximum	Units
Drain to Source Voltage	V <sub>DSS</sub>	68	V
Gate to Source Voltage	V <sub>GSS</sub>	±20	V
Drain Current (DC)	ID	80	А
Drain Current (Pulse), PW≤300μs	I <sub>DP</sub>	320	А
Total Dissipation	P <sub>D</sub>	103	W
Avalanche Energy, Single Pulsed	Eas	364.8	mJ
Junction Temperature	Tj	175	°C
Storage Temperature	T <sub>stg</sub>	-55 to +175	°C

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



#### 5. Thermal Resistance Ratings

Parameter	Symbol	Value	Unit
Junction to case	Rejc	1.46	°C/W

Note 2: When mounted on 1 inch square copper board  $t \le 10$ sec The value in any given application depends on the user's specific board design.

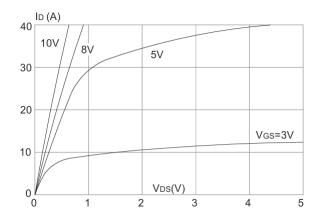
### 6.Electrical Characteristics at Ta=25°C (Note 3)

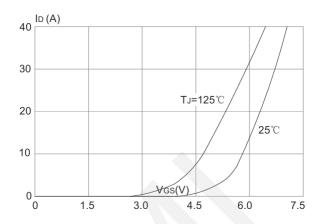
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Drain to Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$I_D = 250 \mu A$ , $V_{GS} = 0 V$	68	-	-	V
Zero-Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 68V, V <sub>GS</sub> = 0V	-	1	1	μΑ
Gate to Source Leakage Current	I <sub>GSS1</sub>	$V_{GS} = \pm 20V$ , $V_{SS} = 0V$	ı	-	±100	nA
Gate Threshold Voltage	$V_{GS(th)}$	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>DS</sub> =250µA	2.4	2.9	3.7	V
Static Drain to Source On-State Resistance	R <sub>DS(on)</sub>	I <sub>D</sub> = 30A, V <sub>GS</sub> = 10V	1	6.3	7.6	mΩ
Input Capacitance	Ciss	V <sub>GS</sub> =0V,	-	4190	-	pF
Output Capacitance	Coss	V <sub>DS</sub> =30V,	-	236	-	pF
Reverse Transfer Capacitance	Crss	Frequency=1.0MHz	-	51	-	pF
Turn-on Delay Time	t <sub>d(on)</sub>		-	15	-	ns
Rise Time	tr	$V_{DS} = 30V, I_{D} = 30A,$	-	90	-	ns
Turn-off Delay Time	t <sub>d(off)</sub>	$V_{GS} = 10V$ , $R_G = 3\Omega$	-	45	-	ns
Fall Time	t <sub>f</sub>		-	30	-	ns
	$Q_g$	V <sub>DS</sub> = 30V,	-	35	-	nC
Total Gate Charge	Qgs	$V_{GS} = 30V$ , $V_{GS} = 10V$ ,	-	10	-	nC
	$Q_{gd}$	I <sub>D</sub> = 30A	-	9	-	nC
Diode Forward Voltage	V <sub>FSD</sub>	I <sub>S</sub> = 30A, V <sub>GS</sub> = 0	0.5	-	1.2	V

Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

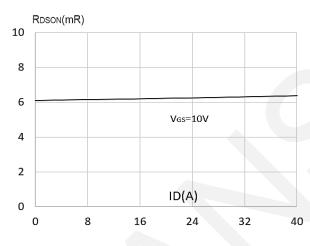


## 7. Typical electrical and thermal characteristics

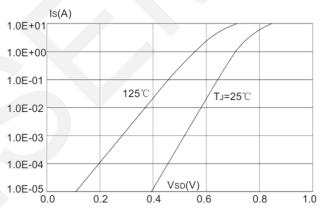




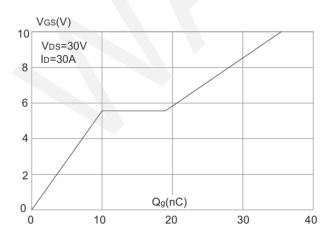
#### **Output Characteristics**



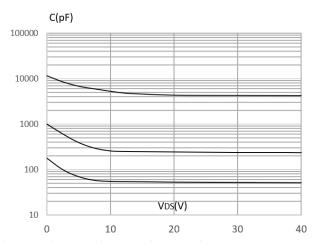
Typical Transfer Characteristics



On-resistance vs. Drain Current



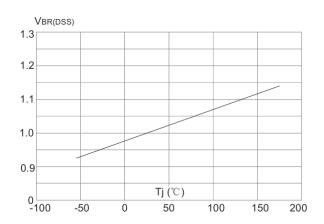
**Body Diode Characteristics** 

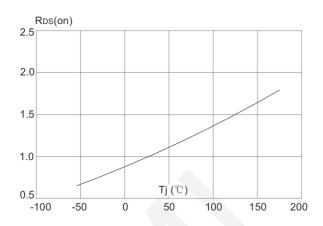


Gate Charge Characteristics

Capacitance Characteristics

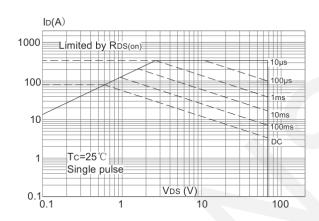






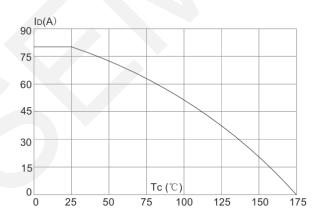
Normalized Breakdown Voltage vs.

Junction Temperature

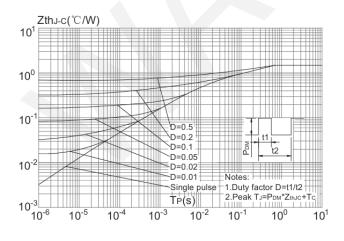


Normalized on Resistance vs.





Maximum Safe Operating Area



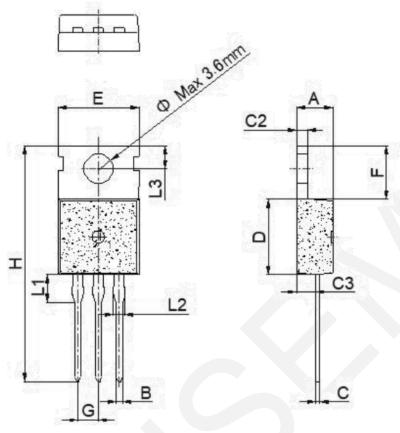
Maximum Continuous Drain Current vs.

Case Temperature

Normalized Maximum Transient Thermal Impedance



## 8.Package Dimensions



Ref.	Dimensions							
		Millimeters			Inches			
	Min.	Тур.	Max.	Min.	Тур.	Max.		
Α	4.40		4.60	0.173		0.181		
В	0.70		0.90	0.028		0.035		
С	0.45		0.60	0.018		0.024		
C2	1.23		1.32	0.048		0.052		
C3	2.20		2.60	0.087		0.102		
D	8.90		9.90	0.350		0.390		
E	9.90		10.3	0.390		0.406		
F	6.30		6.90	0.248		0.272		
G		2.54			0.1			
Н	28.0		29.8	1.102		1.173		
L1		3.39	607		0.133	9 176 10		
L2	1.14		1.70	0.045		0.067		
L3	2.65		2.95	0.104		0.116		
Ф		3.6			0.142			



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